


<b>Search Notes</b>  	<b>Application/Control No.</b>  10780597	<b>Applicant(s)/Patent Under Reexamination</b>  KATAYAMA ET AL.
	<b>Examiner</b>  Lewis, Cheryl	<b>Art Unit</b>  2167

SEARCHED			
Class	Subclass	Date	Examiner
707	100 and 102	11/6/2008	CL
715	200	11/6/2008	CL

SEARCH NOTES		
Search Notes	Date	Examiner
searched WEST US Patents, Pre-Grant Publications, JPO Abstracts, and EPO Abstracts	11/6/2008	CL
searched IBM Disclosure and Derwent Patents	11/6/2008	CL
searched Google Scholar, INSPEC database, and ACM Library	11/6/2008	CL
text searched class: 707 and subclasses: 100 and 102	11/6/2008	CL
text searched class: 715 and subclass 200	11/6/2008	CL
Inventor Name Search	11/6/2008	CL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same as	above	11/6/2008	CL

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